

13. TEST SETUP PHOTOGRAPHS

FCC ID: ZNFL63BL		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 0Y1612272017.ZNF	Test Dates: 12/28/2016 - 12/29/2016	DUT Type: Portable Handset	Page 48 of 50	

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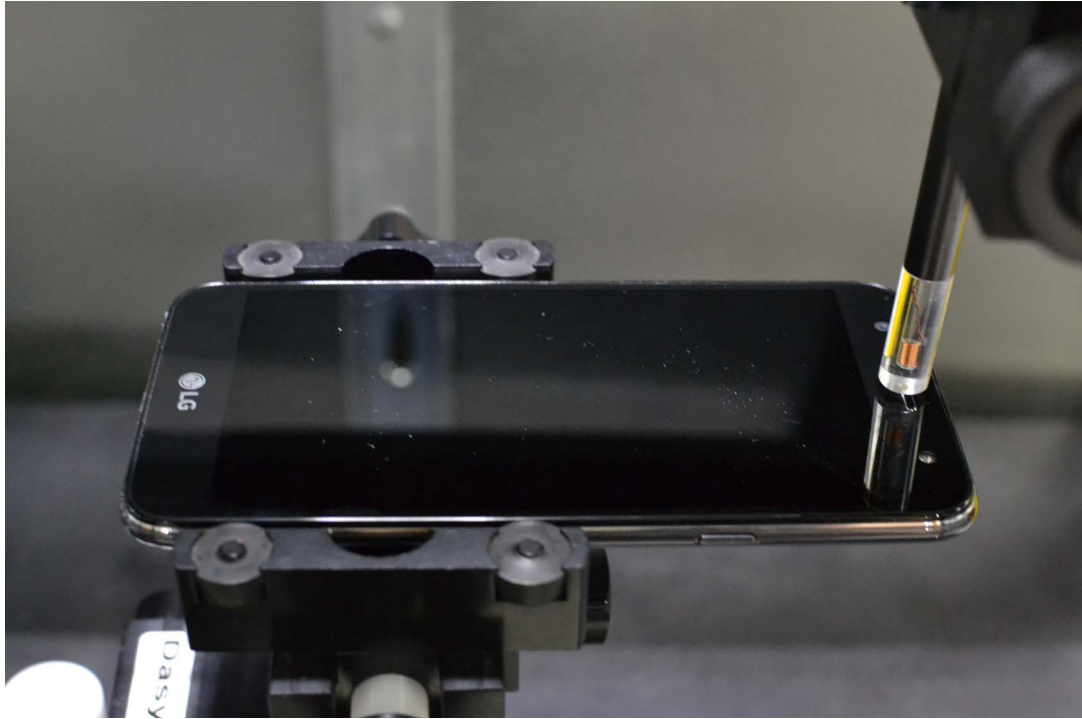


Figure 13-1
Test Setup for Wireless Device

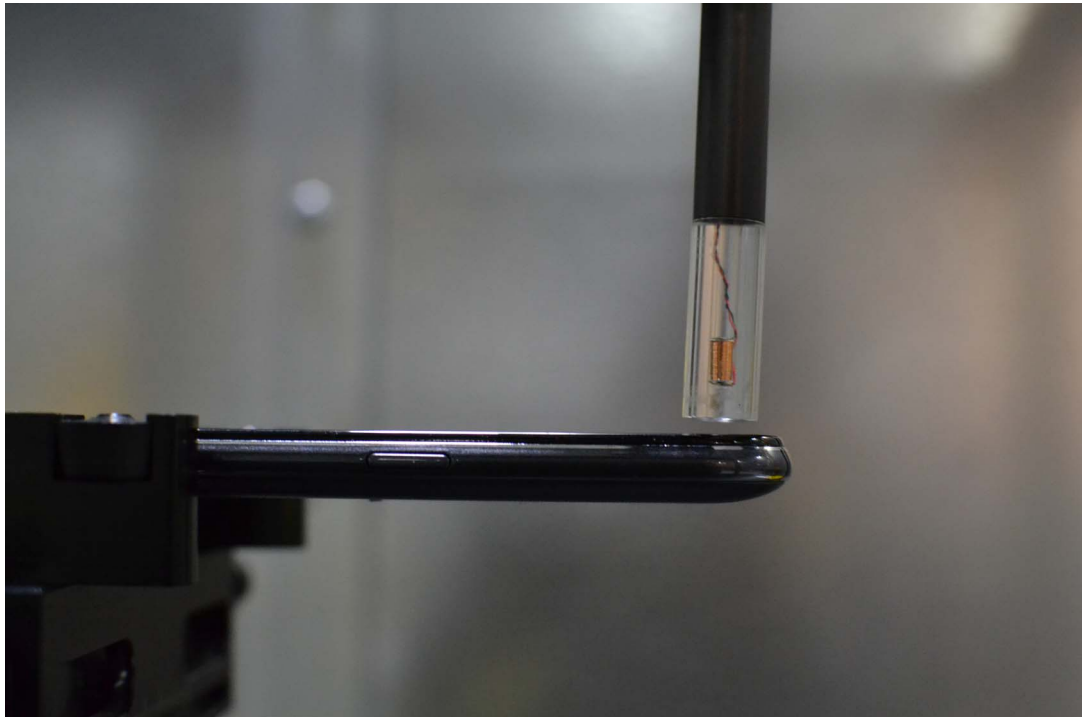


Figure 13-2
Test Setup for Wireless Device

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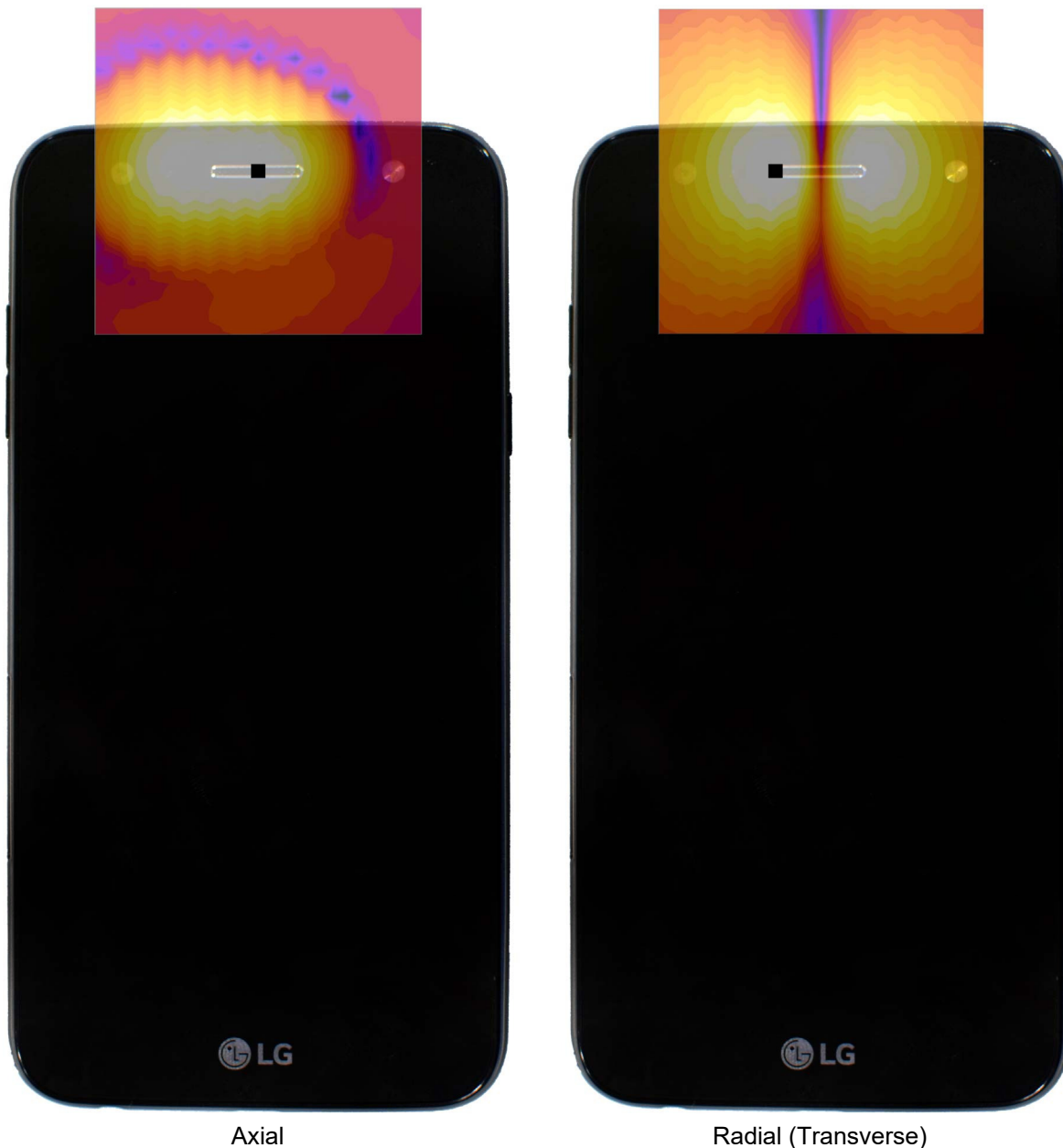


Figure 13-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

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